

# Analytical Reference Materials International

## Certificate of Analysis Certified Reference Material



Grade: **Maraging 300 / UNS K93120**

Part Number (Q.A. NO.): **IARM 99B**

Certification Date: **09/18/2000**

Certificate No.: **99B-09182000-IARM-F**

Revision Date: **04/30/2003**

### Interpretation of Data

1. Certified values listed below reflect analysis results submitted by qualified analytical laboratories using a combination of methods and instrumentation that emulate actual methods and instrumental techniques currently utilized in the analytical community.
2. Any data reported and enclosed by a **parentheses ( )** is a **"best estimate"** and is **NOT CERTIFIED**. This data could not be quantified sufficiently for certification. It was however, reported by enough laboratories to be considered as potentially present in the matrix of the material being examined.
3. The "Inter-laboratory Analysis Program" (ILAP) utilized in the establishment of the data are an ongoing program with permanent membership. Certain elements may be selected by a consensus of the members for more extensive testing. Therefore the data in **brackets [ ]** indicates **further testing is in process**.
4. The "**± Confidence Interval at 95%**" is enclosed by a **parentheses ( )** below the individual element's concentration.

**IMPORTANT:** A "User Registration Card" accompanies all shipments. This card should be completed immediately upon receipt of materials with the appropriate user information. This is the only way in which ARMI can guarantee customer updates or possible data modifications!

<u>Aluminum</u> 0.095 (0.005)	<u>Boron</u> 0.0026 (0.0004)	<u>Carbon</u> 0.005 (0.001)	<u>Cobalt</u> 9.24 (0.06)	<u>Chromium</u> 0.081 (0.002)	<u>Copper</u> 0.094 (0.004)	<u>Manganese</u> 0.036 (0.002)
<u>Molybdenum</u> 4.88 (0.05)	<u>Nitrogen</u> 0.0011 (0.0004)	<u>Niobium</u> (0.005)	<u>Nickel</u> 18.46 (0.06)	<u>Oxygen</u> 0.0015 (0.0004)	<u>Phosphorus</u> 0.005 (0.001)	<u>Sulfur</u> 0.0005 (0.0001)
<u>Silicon</u> 0.022 (0.002)	<u>Tin</u> (0.003)	<u>Titanium</u> 0.74 (0.01)	<u>Vanadium</u> 0.012 (0.004)	<u>Tungsten</u> 0.016 (0.007)		

The laboratories participating in the "Inter-Laboratory Analysis Program" (ILAP) and certification of this material are as follows:

AK Steel, Butler Works - Butler, PA

Allegheny Ludlum Corp. - Brackenridge, PA

Anderson Laboratories, Inc. - Greendale, WI

Chicago Spectro Service Laboratories - Chicago, IL

Jorgensen Forge Corp. - Seattle, WA

Lockheed Martin Astronautics - Littleton, CO

Allegheny Ludlum Corp. - Brackenridge, PA

Allvac Lockport - Lockport, NY

Carpenter Technology Corporation - Reading, PA

Conam Inspection - Gary, IN

Laboratory Testing, Inc. - Hatfield, PA

Wisconsin Centrifugal, Inc. - Waukesha, WI

**Traceability:** All members of the "Inter-Laboratory Analysis Program" (ILAP) listed above validate test methods and instrument performance utilizing SRMs produced by the National Institute of Standards and Technology, (NIST) as well as other CRMs and RMs produced by recognized Certifying Bodies from around the world. The specific SRMs, CRMs and RMs applicable to the material covered by this certificate are: NIST 1226, 1261A, 1262A, 1265A, C1151, C1152, C1153, C1154, 1155, 1193, 1194, 1195, 1230, C2400, JSS 650, 651, 652, 653, 654, 655, BCS331, 332, 333, 334, 335, 336, 337, 338, ARMCO 8709, 8710, 8711, 8712, MBH14933, 14934, 14935, BSC 401/1, 402/1, 403/1, 404/1, 405/1, 406/1, 407/1, 408/1, 409/1, 410/1, IARM 1B, 2B, 4B, 5B, 9B, 11B, 152A, 157A162A, 163A, 205A, 27B, 28B, 29B, 30B, 31B, 32B, 33B, 34B, 35B, 36B, 48B, 49B, 155A, 156A, 164A, 165A, 166A, 167A, 168A, 169A, 170A, 171A, 172A, NIST 1156, IARM 99A, NIST 1156, IARM 99A, LECO 502-148, 501-550, NIST 121D, 133A, 1091A, BS 160, 160A, NIST 1156, 897, 898, IARM 99A, NIST 15H, 343A, 73C, AK 420400, 220790, V3017-1, V3017-2, B-85, BS CA316-3, 84J, SS 466, LECO 502-106, NIST 1156, 443, 444, IARM 99A, LECO 501-676, 501-553, NIST 362, IARM 27B, CS 793, LECO 501-647, CT 204, 300, BS 161, CSN-4, IARM 99A, LECO 501-674, 501-643, 14934K, 14935L, LECO 502-148, 501-550

A specific line of traceability is established to NIST and other Certifying Bodies for those elements that are noted as "Certified Values" on the Certificates of Analyses referenced above.

**See Reverse Side for Statistical Data and Additional Information Regarding this Material.**

The following data and accompanying statements represent all pertinent information reported in the ILAP as it applies to the chemical characterization of this material as of 04/30/2003.

99B	Al	B	C	Co	Cr	Cu	Mn	Mo	N	Nb	Ni	O	P	S	Se
1	0.0850	0.0021	0.0048	9.29	0.080	0.094	0.03519	4.81	0.0005	0.0049	18.60	0.0012	0.004	0.0006	<0.0001
2	0.1046	0.0025	0.005	9.445	0.077	0.096	0.0322	4.761	0.00123	<0.01	18.466	0.00102	0.007	0.0004	<0.0001
3	0.091	0.0021	0.00675	9.22	0.0847	0.0981	0.0380	4.972	0.0013	0.0052	18.32	0.0020	0.0073	0.0004	<0.001
4	0.110	0.00279	0.005	9.083	0.084	0.0873	0.031	4.84	0.0019	0.0043	18.416	0.0013	0.00600	0.0005	
5	0.100	0.0033	0.0042	9.30	0.085	0.102	0.037	5.020	0.0010	0.011	18.399	0.0020	0.0048	0.00045	
6	0.092	0.0025	0.0065	9.260	0.083	0.102	0.038	4.814	0.0004	0.0233	18.610	0.0017	0.0066	0.0007	
7	0.095	0.0029	0.0039	9.220	0.083	0.090	0.038	4.906	0.0020	0.001	18.506		0.0045	0.0003	
8	0.089		0.0039	9.13	0.081	0.090	0.037	4.804	0.0013	0.006	18.33		0.0044	0.0004	
9	0.093			9.15	0.079	0.089		4.95	0.0011		18.53		0.0048	0.0004	
10	0.091			9.330	0.077	0.088		4.85	0.0007		18.481		0.0039		
11				9.32				4.880			18.47		0.006		
12				9.13				4.81			18.45				
13								5.00							
Mean	0.0951	0.0026	0.0050	9.2398	0.0814	0.0936	0.0358	4.8782	0.0011	0.0080	18.4648	0.0015	0.0054	0.0005	#DIV/0!
STDV.	0.0076	0.0004	0.0011	0.1048	0.0030	0.0056	0.0028	0.0840	0.0005	0.0074	0.0913	0.0004	0.0012	0.0001	#DIV/0!
Certified	0.095	0.0026	0.005	9.24	0.081	0.094	0.036	4.88	0.0011	(0.005)	18.46	0.0015	0.005	0.0005	
95% C.I.	0.005	0.0004	0.001	0.06	0.002	0.004	0.002	0.05	0.0004		0.06	0.0004	0.001	0.0001	
Methods	X,D,I,O	D,I,O	C	X,D,I,O	X,D,I,O	X,D,I,O	X,D,I,O	X,D,I,O	F	X,D,I,O	X,W,O	F	X,D,I,O	C	

Methods: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G=GDMS

99B	Si	Sn	Ta	Ti	V	W	Ag	As	Bi	Ca	Mg	Pb	Te	Zn	Zr
1	0.0197	0.002	0.0209	0.73	0.0061	0.02795	<0.0001	0.0050	0.0001	0.0152	<0.0001	0.0031	0.0023	0.0474	0.0074
2	0.024	0.0108	0.0524	0.768	0.0103	0.0096	0.0005	0.0040	<0.0001	0.0001	0.0005	0.0003	<0.0001	0.0050	0.01
3	0.022	0.0029	<0.005	0.72	0.0116	0.0070		0.0121		<0.0005	0.0003	<0.00005		0.0045	0.0013
4	0.0235	0.0128	<0.01	0.7277	0.0185	0.021					<0.001	<0.0005			0.013
5	0.023	0.00535		0.759	0.008	0.009						0.0002			
6	0.018	0.0021		0.727	0.015	0.017						<0.001			
7	0.021	0.0022		0.734		0.023									
8				0.726											
9				0.74											
10				0.756											
11				0.74											
Mean	0.0216	0.0055	0.0367	0.7389	0.0116	0.0164	0.0005	0.0070	0.0001	0.0077	0.0004	0.0012	0.0023	0.0190	0.0079
STDV.	0.0022	0.0045	0.0223	0.0156	0.0046	0.0080	#DIV/0!	0.0044	#DIV/0!	0.0107	0.0001	0.0016	#DIV/0!	0.0246	0.0050
Certified	0.022	(0.003)		0.74	0.012	0.016									<0.01
95% C.I.	0.002			0.01	0.004	0.007									
Methods	X,D,I,O	X,A,O		X,D,I,O	X,I,O	X,D,I,O									X,D,I

Methods: W = Classical, C = Combustion, F = Fusion, A = AA or GFAA, I = ICP or DCP, D = DC Arc, O = OE, X = XRF, G=GDMS

The International Standards Organization (ISO) definitions, expressed in ISO Guide 30-1992 list the following:

**Certifying Body:** Any technically competent body (organization or firm, public or private) that issues a reference material certificate, which provides the information, detailed in ISO Guide 31. The only generally accepted certifying body in the United States for primary standards - Standard Reference Materials (SRM) is the U. S. Department of Commerce, National Institute of Standards & Technology, (NIST), Gaithersburg, MD. All other certifying bodies in the United States produce Reference Materials (RM) or Certified Reference Materials (CRM).

**Reference Material (RM):** Material or substance one or more of whose property values are sufficiently homogeneous and well established to be used for the calibration of an apparatus, the assessment of a measurement method, or for assigning values to materials.

**Certified Reference Material (CRM):** Reference material, accompanied by a certificate, one or more of whose property values are certified by a procedure, which establishes its traceability to an accurate realization of the unit in which the property values are expressed, and for which each certified value is accompanied by an uncertainty at a stated level of confidence.


**Inter-Laboratory Analysis Program (ILAP):** Although ASTM Standard E691-87 applies to inter-laboratory studies to "Determine the Precision of a Single Test Method", it is also a well thought out and logical plan for conducting an inter-laboratory program involving multiple techniques. Therefore, the planning, conducting, analyzing, protocol, and treatment of data resulting from this inter-laboratory program were performed utilizing the guidelines established in ASTM E691-87.

**Methods of Analysis:** In view of the fact, that the "Inter-Laboratory Analysis Program" entails a wide variety of materials, no single analytical method would provide optimum data results. Therefore, the methods utilized were a combination of ASTM Standard Methods for classical wet chemistry, ICP, AA, Optical Emission, and X-Ray spectrometric methods. The determinations for Carbon, Sulfur, Nitrogen, and Oxygen are the result of combustion and OE instrument procedures.

**Expiration of Certification:** The certification of this IARM is valid indefinitely, within the uncertainty specified, provided the IARM is handled and stored in accordance with the instructions stated on this certificate. The certification is nullified if the IARM is damaged, contaminated, otherwise modified, or used in a manner for which it was not intended.

**Instructions for Use:** The test surface is the side opposite to the labeled surface, which includes the IARM number. The entire thickness of the unit is certified. However, the user is cautioned not to measure disks less than 2 mm thick when using X-ray fluorescence spectrometry. Each packaged disk has been prepared by finishing the test surface using a lathe. The user must determine the correct surface preparation procedure for each analytical technique. The user is cautioned to use care when either resurfacing the disk or performing additional polishing as these processes may contaminate the surface. When not in use, the material should be stored in a cool, dry location. This material was tested using both the solid disks and chips prepared from the disks. The certified values are considered representative of the overall average composition of the material. **Chips are not intended for Oxygen analysis.**

**Selection of Materials:** A "batch" or "series" is defined as a single bar of one continuous length and heat. The majority of materials are in wrought condition; other methods of manufacture are utilized as a less desirable resort. ILAP samples are taken by removing a section, a minimum of, every one-twelfth of total length from the entire bar. A portion of the section is converted to chips and thin (pin) disk for analysis by classical wet chemistry, ICP, AA, and combustion procedures, and the balance remains as a thick disk for OES and X-Ray analysis. This systematic sampling procedure results in the homogeneity being reflected as a product of the overall statistics and certified data. This method of homogeneity testing is in accordance with ISO Guide 34, regarding the systematic selection and testing of a representative number of units for the assessment of homogeneity.

Certified by:   
 William D. Britt, President & General Manager  
 Analytical Reference Materials International Corporation

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